

Driver / MOSFET Combination DEIC-515 Driver combined with a DE375-102N12A MOSFET Gate driver matched to MOSFET

1000 Volts 12 A 0.7 Ohms

Features

- Isolated Substrate
 - high isolation voltage (>2500V)
 - excellent thermal transfer
 - Increased temperature and power cycling capability
- IXYS advanced Z-MOS process
- Low R_{DS(on)}
- Very low insertion inductance (<2nH)
- No beryllium oxide (BeO) or other hazardous materials
- Built using the advantages and compatibility of CMOS and IXYS HDMOS™ processes
- Latch-Up Protected
- Low Quiescent Supply Current

Advantages

- · Optimized for RF and high speed
- · Easy to mount—no insulators needed
- · High power density
- · Single package reduces size and heat sink area



Applications

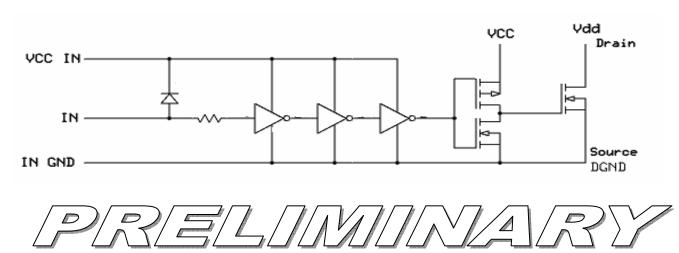
- Class D or E Switching Amplifier
- Multi MHz Switch Mode Power Supplies (SMPS)

Description

The IXZ4DF12N100 is a CMOS high speed high current gate driver and a MOSFET combination specifically designed Class D, E, HF, RF applications at up to 40MHz, as well as other applications. The IXZ4DF12N100 in pulse mode can provide 72A of peak current while producing voltage rise and fall times of less than 5ns, and minimum pulse widths of 8ns. The input of the driver is fully immune to latch up over the entire operating range. Designed with small internal delays, the IXZ4DF12N100 is suitable for higher power operation where combiners are used. Its features and wide safety margin in operating voltage and power make the IXZ4DF12N100 unmatched in performance and value.

The IXZ4DF12N100 is packaged in DEIs low inductance RF package incorporating DEI's RF layout techniques to minimize stray lead inductances for optimum switching performance. The IXZ4DF12N100 is a surface-mountable device.

Figure 1. Functional Diagram





Device Specifications

Parameter	Value
Maximum Junction Temperature	150°C
Operating Temperature Range	- 40°C to 85°C
Weight	5.5q

Symbol	Test Conditions	Maximum Ratings
fmax	ID = 0.5IDM25	40MHz
VDSS		1000V
Vcc, Vccin		20V
loss	Vps = 0.8Vpss	50uA
	$VGS = 0V$ $T_J = 125C$	1mA
IDM25	Tc = 25°C	12A
Ірм	Tc = 25°C, Pulse limited by Т _Ј м	72A
lar	Tc = 25°C	12A
PT (MOSFET and Driver)	Tc = 25°C	TBD 500W
RthJC		0.25 °C/W
RthJHS		TBD °C/W

Device Performance

Symbol	Test Condition	Minimum	Typical	Maximum
Rds(ON)	V _{CC} = 15V, I _D = 0.5I _{DM25} Pulse Test, t ≤ 300μS, Duty Cycle ≤ 2%		0.7 Ω	
Vcc, Vccin		8V	15V	20V
IN (Signal Input)		- 5V		VCCIN+0.3V
VIH (High Input Voltage)		V _{CCIN} -2V		Vccin+0.3V
VIL (Low Input Voltage)			V8.0	
Zin	f = 1MHz		7960 Ω	
Cstray	f = 1MHz Any one pin to the back plane metal		46pf	
Coss	$V_{GS} = 0V$, $V_{DS} = 0.8V_{DSS(max)}$, f = 1MHz		150pf	
tondly	$T_{C} = 25^{\circ}C$ $V_{CC}, V_{CCIN}, V_{IN} = 15V 1\mu S \text{ Pulse},$ $V_{DS} = 50V, R_{L} = 2.5\Omega$		20nS	
t offdly			22.6nS	
t R	$T_{C} = 25^{\circ}C$ $V_{CC}, V_{CCIN}, V_{IN} = 15V 1\mu S \text{ Pulse},$ $V_{DS} = 50V, R_{L} = 2.5\Omega$		3nS	
tғ			4.5nS	



Fig. 2 Extended Output Characteristics @ 25°C

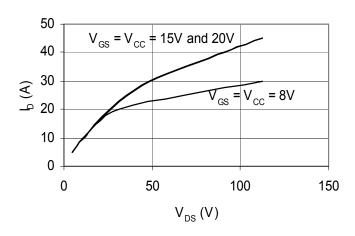


Fig. 3 $R_{DS(ON)}$ vs. Temperature $I_D = 0.5I_{DM}$ 2.5

2

2

3

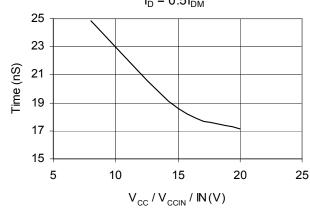
0.5

0

70

Temperature (C)

Fig. 4 Propagation Delay ON vs. Supply Voltage $I_D = 0.5I_{DM}$



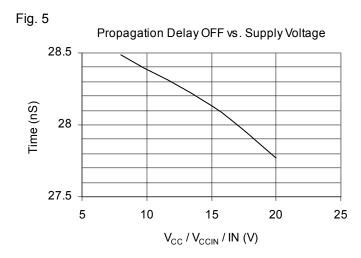
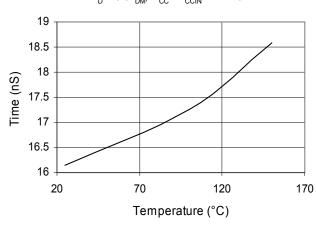
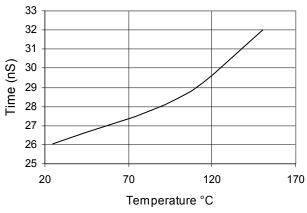


Fig. 6 Propagation Delay ON vs.Temperature $I_D = 0.5 \ I_{DM}, \ V_{CC} / \ V_{CCIN} / \ IN = 15 V$

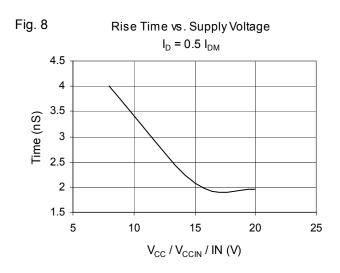


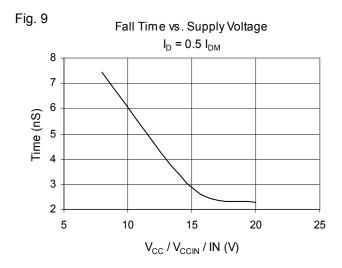


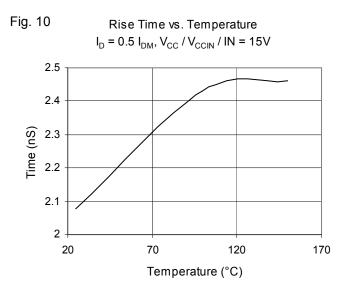


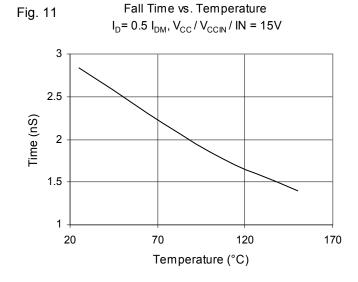
PRELIMINALY

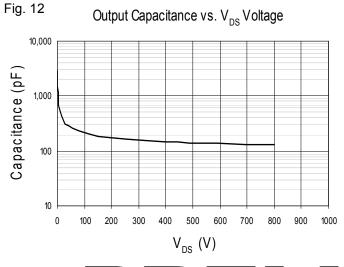












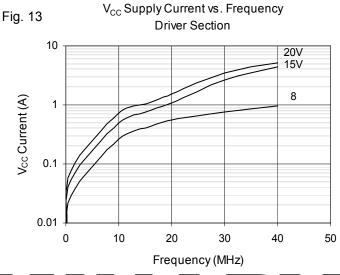
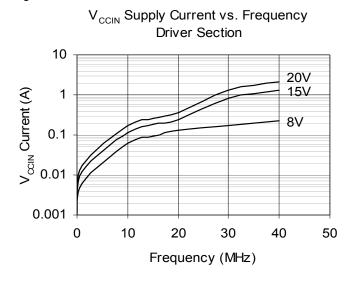
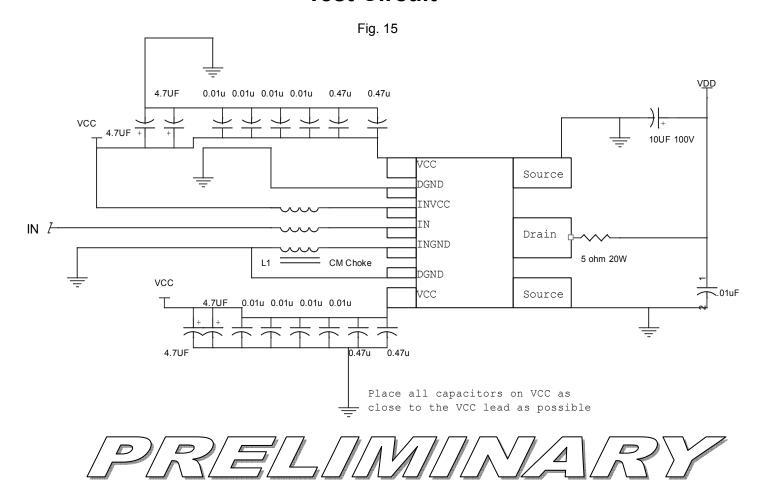




Fig. 14



Test Circuit





Lead Description

SYMBOL	FUNCTION	DESCRIPTION	
Drain	MOSI ET DIAIII	Drain of Power MOSFET.	
Source	MOSFET Source	Source of Power MOSFET. This connection is common to DGND.	
VCC		Power supply input for the driver output section. These leads provide power to the output section of the DEIC515 driver. Both leads must be connected.	
VCCIN		Input for the positive input section power-supply voltage. This lead provides power to the input section of the DEIC515 driver. This lead should not be directly connected to VCC.	
IN	Input	Input signal.	
DGND	Power Driver	The system ground leads. Internally connected to all circuitry, these leads provide ground reference for the entire chip. These leads should be connected to a low noise analog ground plane for optimum performance.	
INGND	Input Section	The input section ground lead. This lead is a Kelvin connection internally connected to DGND. This lead must not be connected to DGND as excessive current can damage this lead.	

IXYS RF reserves the right to change limits, test conditions and dimensions without notice.

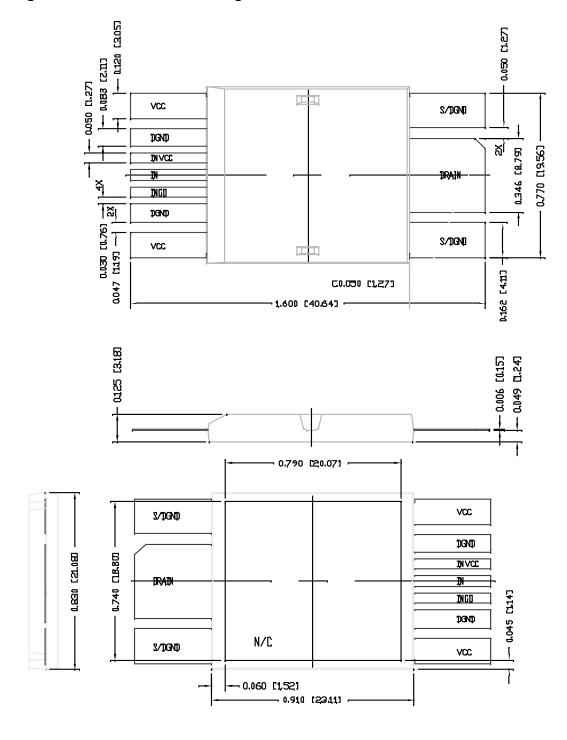
IXYS RF MOSFETS are covered by one or more of the following U.S. patents:

4,931,844 4,835,592 4,860,072 4,881,106 4,891,686 5,017,508 5,034,796 5,063,307 5,187,117 5,237,481 5,486,715 5,049,961 5,381,025 5,640,045 6,404,065 6,583,505 6,710,463 6,727,585 6,731,002





Fig. 16 IXZ4DF12N100 Package Outline



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